

ECE606: Solid State Devices

Lecture 14

Electrostatics of p-n junctions

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- 1) **Introduction to p-n junctions**
- 2) Drawing band-diagrams
- 3) Accurate solution in equilibrium
- 4) Band-diagram with applied bias

Ref. Semiconductor Device Fundamentals, Chapter 5

solar cells



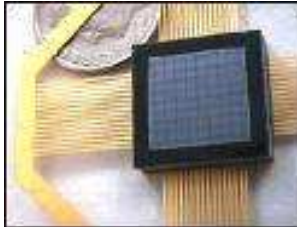
GaAs lasers



Organic LED



Avalanche Photodiode

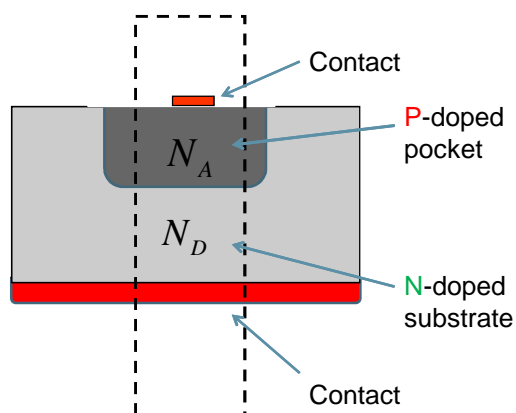


GaN lasers

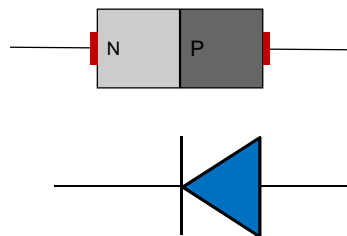


Image.google.com

Schematic of a p-n Diode



Symbol



Point-contact diode



Topic Map (Today : Diode in Equilibrium)

	Equilibrium	DC	Small signal	Large Signal	Circuits
Diode					
Schottky					
BJT/HBT					
MOS					

Diode in Equilibrium.
(No external voltage applied)

Drawing Band Diagram in Equilibrium...

Previously constant in homogeneous semiconductors. But for pn diode: $f(x)$!!

$$\nabla \cdot D = q(p - n + N_D^+ - N_A^-)$$

$$\frac{\partial n}{\partial t} = \frac{1}{q} \nabla \cdot \mathbf{J}_N - r_N + g_N$$

$$\mathbf{J}_N = qn\mu_N E + qD_N \nabla n$$

$$\frac{\partial p}{\partial t} = \frac{-1}{q} \nabla \cdot \mathbf{J}_P - r_P + g_P$$

$$\mathbf{J}_P = qp\mu_P E - qD_P \nabla p$$

Equilibrium (Start here)

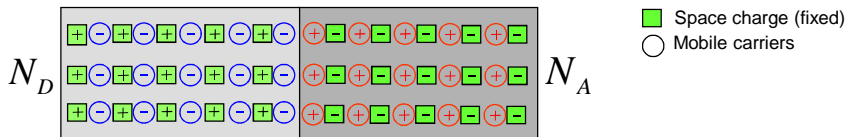
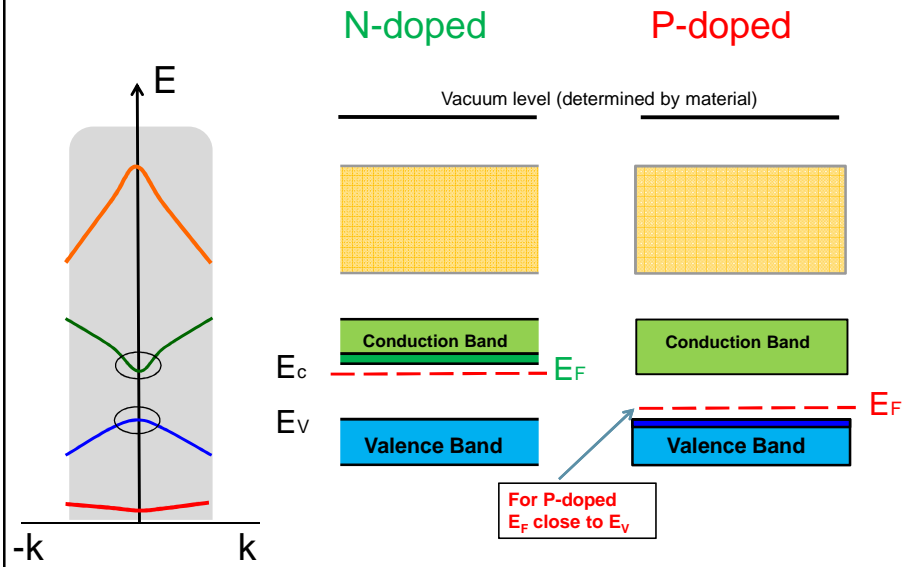
In equilibrium $J=0$ (no current flow).
But, Electric fields or diffusion might still be present. \rightarrow Detailed balance

Non-Equilibrium (refine later)

DC $dn/dt=0$

Small signal $dn/dt \sim j\omega t \times n$

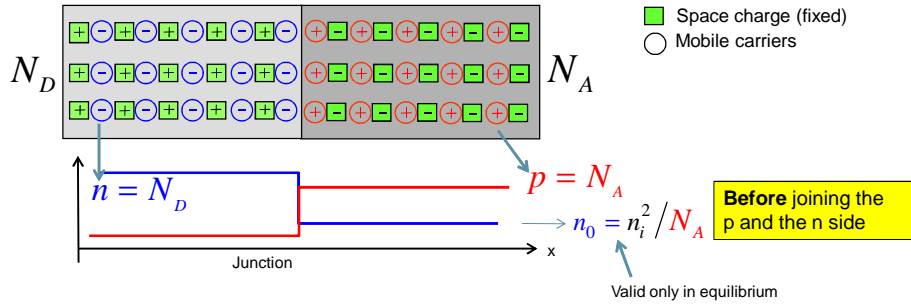
Transient --- full solution



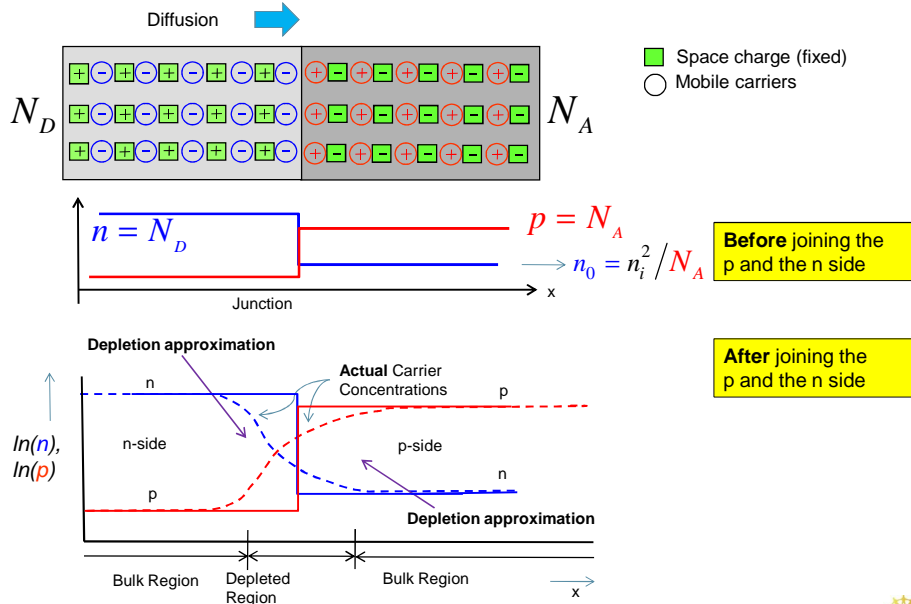
Donor-side (N-side)
Squares are fixed donor atoms. Every donor atom has given away one electron (blue circle)

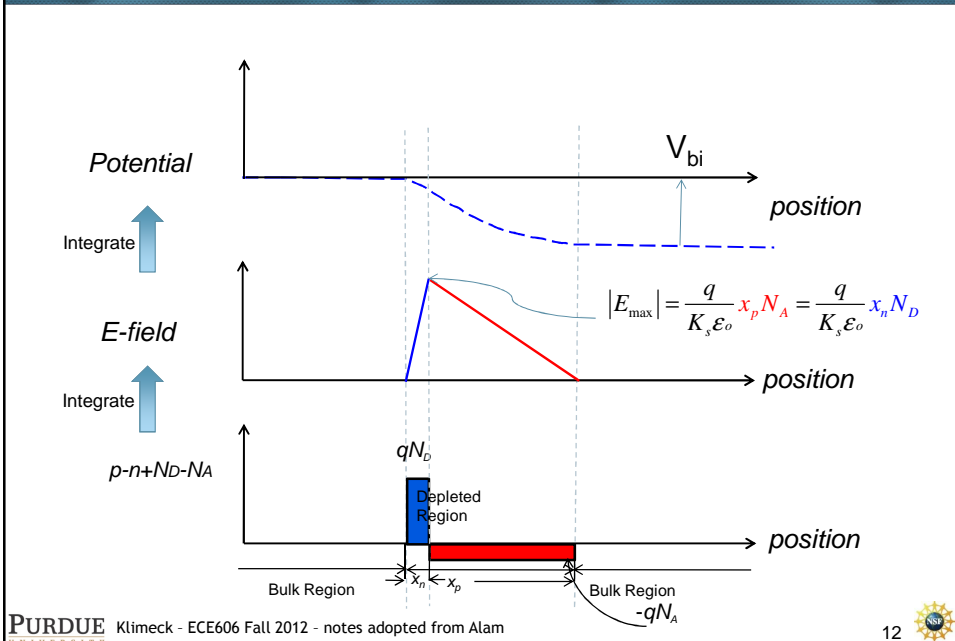
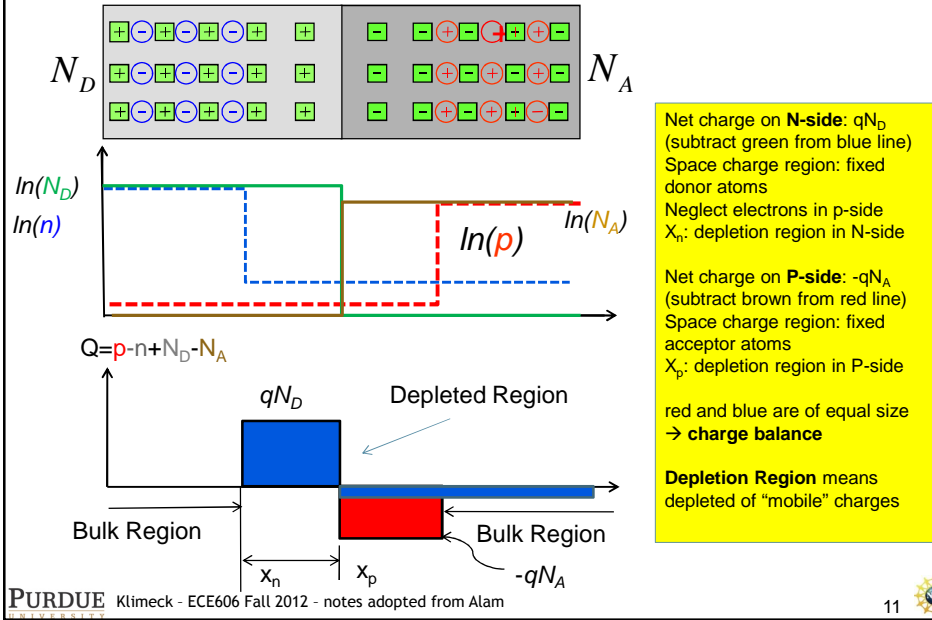
Acceptor-side (P-side)
Squares are fixed acceptor atoms. Every acceptor atom has captured one electron (from the valence band). Every acceptor atom leaves behind one hole in the valence band. (red circle)

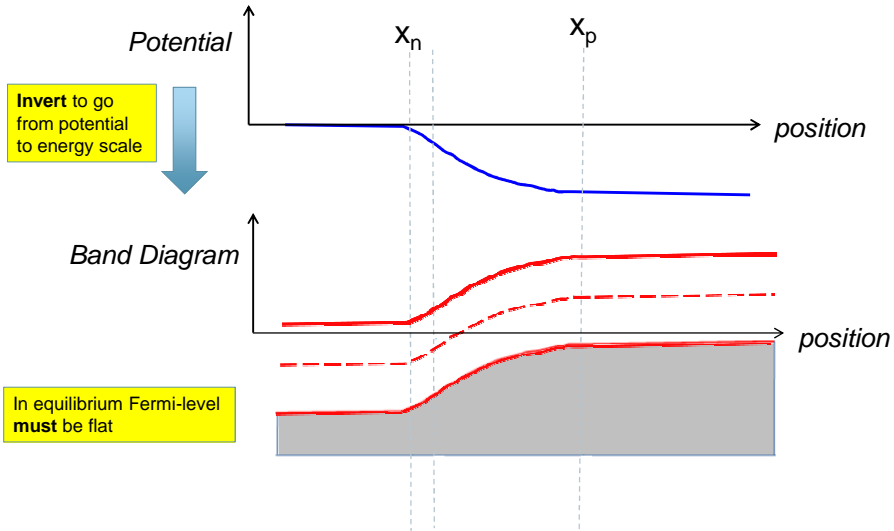
Forming a Junction



Forming a Junction

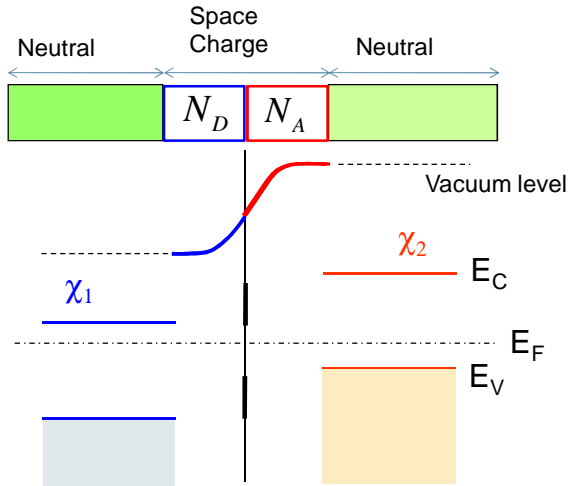






- 1) Introduction to p-n junctions
- 2) **Drawing band-diagrams**
- 3) Analytical solution in equilibrium
- 4) Band-diagram with applied bias

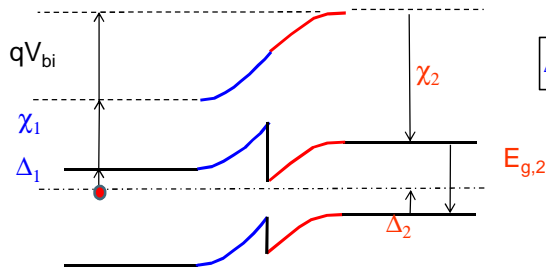




Drawing Recipe

- 1) Start with EF
- 2) Ec/Ev in bulk n-side
- 3) Ec/Ev in bulk p-side
- 4) Vacuum level in N
- 5) Vacuum level in P
- 6) Join vacuum levels
- 7) "Transfer" vacuum level slopes to join Ec/Ev

... is equivalent to solving the Poisson equation



Always true in equilibrium

$$\Delta_1 + \chi_1 + qV_{bi} = \chi_2 + E_{g,2} - \Delta_2$$

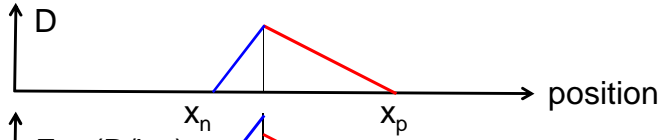
delta_{1,2} determined via doping concentrations

chi_{1,2} material parameters

Built-in potential V_{bi} unknown!

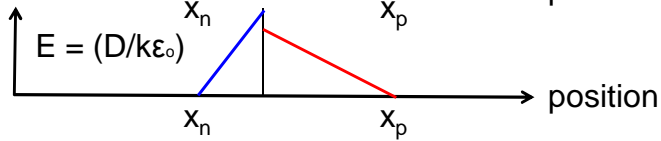
$$\begin{aligned} qV_{bi} &= E_{g,2} - \Delta_2 - \Delta_1 + \chi_2 - \chi_1 \\ &= \left(E_{g,2} + k_B T \ln \frac{N_A}{N_{V,2}} \right) + k_B T \ln \frac{N_D}{N_{C,1}} + (\chi_2 - \chi_1) \\ &= k_B T \ln \frac{N_A N_D}{N_{V,2} N_{C,1} e^{-E_{g,2}/k_B T}} + (\chi_2 - \chi_1) \end{aligned}$$

Homo - Junction



Hetero - Junction

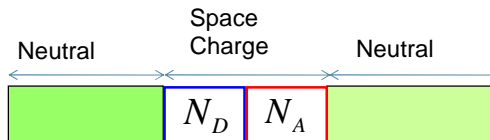
Field not continuous across junction



$$D_1 = K_1 \epsilon_0 E(0^-) = K_2 \epsilon_0 E(0^-) = D_2$$

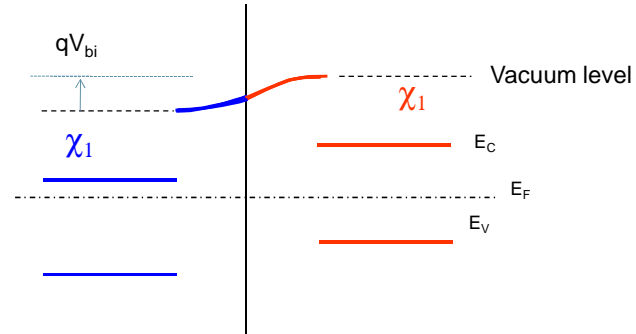
$$E(0^-) = \frac{K_2}{K_1} E(0^+)$$

Displacement is continuous across the interface, field need not be ..



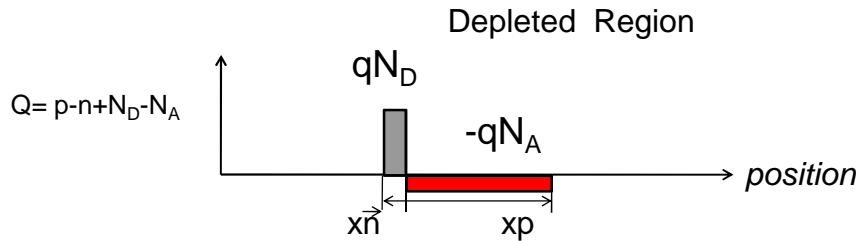
Drawing Recipe

- 1) Start with EF
- 2) Ec/Ev in bulk n-side
- 3) Ec/Ev in bulk p-side
- 4) Vacuum level in N
- 5) Vacuum level in P
- 6) Join vacuum levels
- 7) "Transfer" vacuum slopes to join Ec/Ev

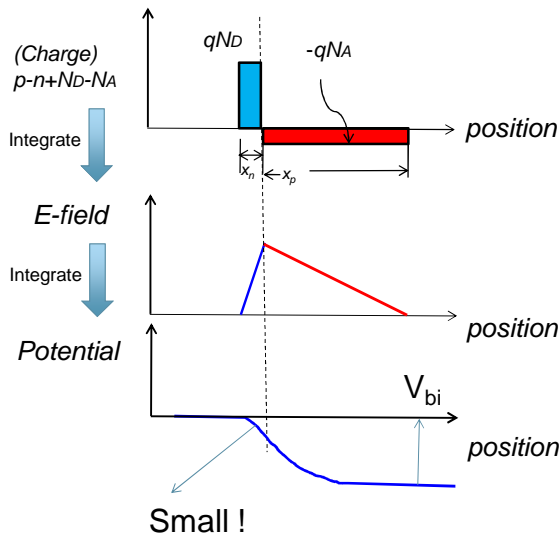


Zero for homo-junctions

$$qV_{bi} = k_B T \ln \frac{N_A N_D}{N_{V,2} N_{C,1} e^{-E_{g,2}/k_B T}} + (\chi_2 - \chi_1) = k_B T \ln \frac{N_A N_D}{N_V N_C e^{-E_g/k_B T}} = k_B T \ln \frac{N_A N_D}{n_i^2}$$



$$K_s \epsilon_0 \frac{d^2 V}{dx^2} = -q(p - n + N_D^+ - N_A^-)$$



E-field

$$E(0^-) = \frac{qN_D x_n}{k_s \epsilon_0}$$

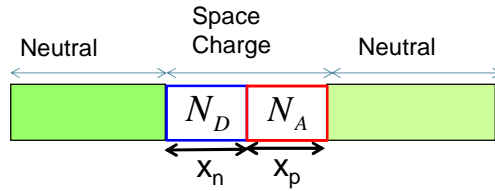
$$E(0^+) = \frac{qN_A x_p}{k_s \epsilon_0}$$

$$\Rightarrow N_D x_n = N_A x_p$$

Integrate ↓ *Potential*

$$qV_{bi} = \frac{E(0^-) x_n}{2} + \frac{E(0^+) x_p}{2}$$

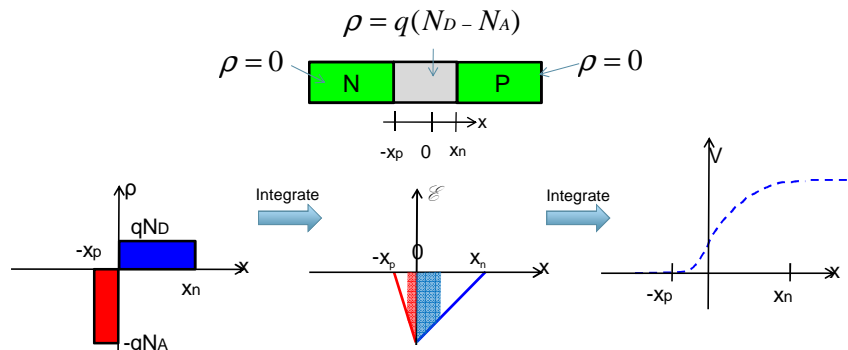
$$= \frac{qN_D x_n^2}{2k_s \epsilon_0} + \frac{qN_A x_p^2}{2k_s \epsilon_0}$$



Solve for x_n, x_p

$$\left. \begin{aligned} N_D x_n &= N_A x_p \\ qV_{bi} &= \frac{qN_D x_n^2}{2k_s \epsilon_0} + \frac{qN_A x_p^2}{2k_s \epsilon_0} \end{aligned} \right\} \begin{aligned} x_n &= \sqrt{\frac{2k_s \epsilon_0}{q} \frac{N_A}{N_D(N_A + N_D)} V_{bi}} \\ x_p &= \sqrt{\frac{2k_s \epsilon_0}{q} \frac{N_D}{N_A(N_A + N_D)} V_{bi}} \end{aligned}$$

Small Project: Solve the same problem for a **hetero-junction**




If you need to calculate electric field at specific points...

$$\frac{d\mathcal{E}}{dx} = \begin{cases} -\frac{qN_A}{K_S \epsilon_0} & -x_p \leq x \leq 0 \\ \frac{qN_D}{K_S \epsilon_0} & 0 \leq x \leq x_n \\ 0 & x \leq -x_p, x \geq x_n \end{cases} \quad \int_{\mathcal{E}(x)}^0 d\mathcal{E}' = \int_x^{-x_p} \frac{qN_D}{K_S \epsilon_0} dx'$$

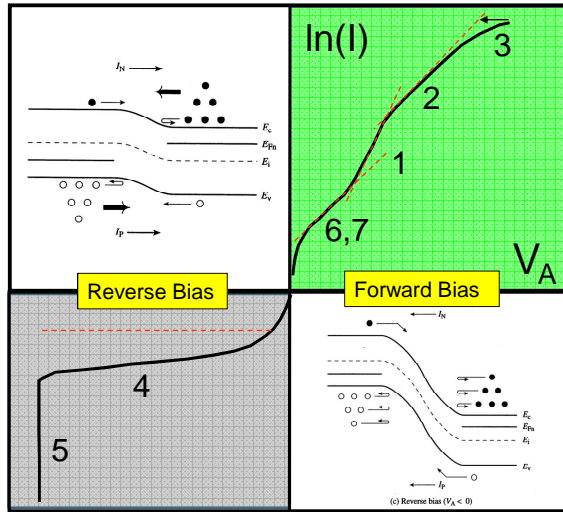
$$\int_0^{\mathcal{E}(x)} d\mathcal{E}' = -\int_{-x_p}^x \frac{qN_A}{K_S \epsilon_0} dx'$$

$$\mathcal{E}(x) = -\frac{qN_A}{K_S \epsilon_0} (x_p + x) \dots -x_p \leq x \leq 0 \quad \mathcal{E}(x) = -\frac{qN_D}{K_S \epsilon_0} (x_n - x) \dots 0 \leq x \leq x_n$$

- 1) Introduction to p-n junction transistors
- 2) Drawing band-diagrams
- 3) Analytical solution in equilibrium
- 4) **Band-diagram with applied bias**

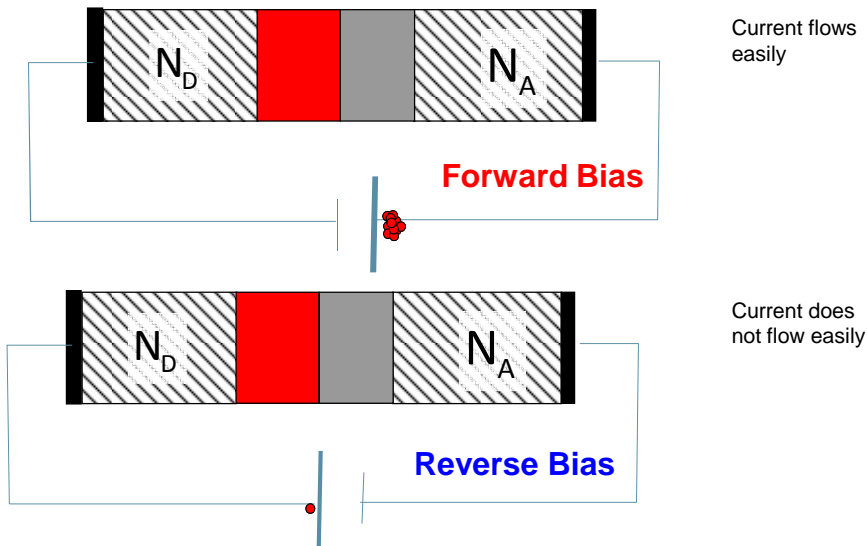
	Equilibrium	DC	Small signal	Large Signal	Circuits
Diode					
Schottky			Diode in Non-Equilibrium (External DC voltage applied)		
BJT/HBT					
MOS					

IV characteristics of a Diode



To be discussed in detail

1. Diffusion limited
2. Ambipolar transport
3. High injection
4. R-G in depletion
5. Breakdown
6. Trap-assisted R-G
7. Esaki Tunneling



$\nabla \cdot D = q(p - n + N_D^+ - N_A^-)$ ← Band diagram (this segment)

$\frac{\partial n}{\partial t} = \frac{1}{q} \nabla \cdot \mathbf{J}_N - r_N + g_N$

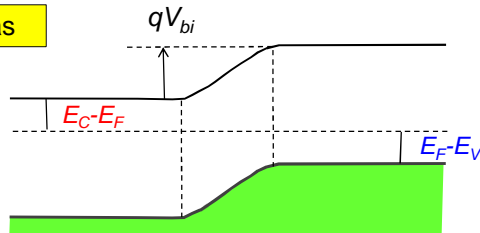
$\mathbf{J}_N = qn\mu_N E + qD_N \nabla n$

$\frac{\partial p}{\partial t} = -\frac{1}{q} \nabla \cdot \mathbf{J}_P - r_P + g_P$

$\mathbf{J}_P = qp\mu_p E - qD_P \nabla p$

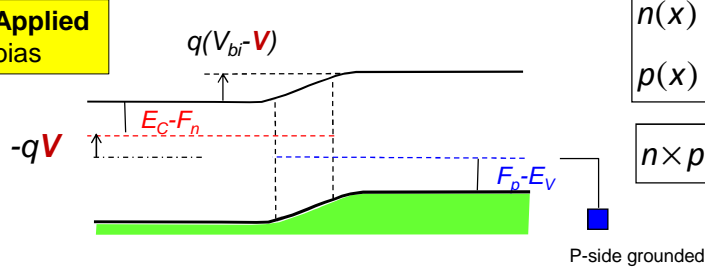
Next segment / lecture ...

No bias



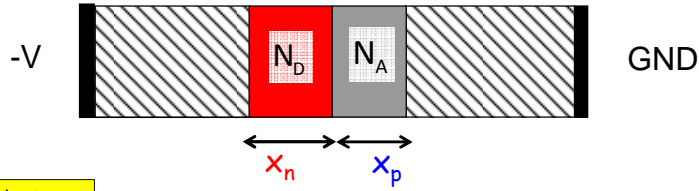
Question: Max value of V_{bi} ?
Answer: for degenerate s.c.,
if $E_C - E_F = 0$, $E_F - E_V = 0 \rightarrow E_g$

Applied bias



$n(x) = n_i e^{(F_n - E_i)\beta}$
 $p(x) = n_i e^{-(F_p - E_i)\beta}$

$n \times p = n_i^2 e^{(F_n - F_p)\beta}$



From previous lecture (homo-junction)

$$N_D x_n = N_A x_p$$

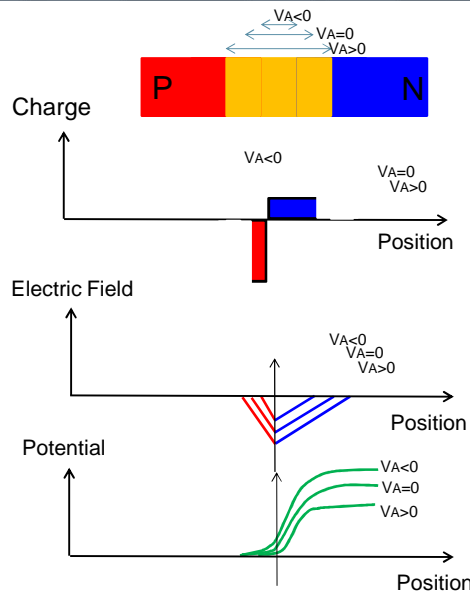
$$q(V_{bi} - V) = \frac{qN_D x_n^2}{2k_s \epsilon_0} + \frac{qN_A x_p^2}{2k_s \epsilon_0}$$

$$x_n = \sqrt{\frac{2k_s \epsilon_0}{q} \frac{N_A}{N_D (N_A + N_D)} (V_{bi} - V)}$$

$$x_p = \sqrt{\frac{2k_s \epsilon_0}{q} \frac{N_D}{N_A (N_A + N_D)} (V_{bi} - V)}$$

Applied bias

What about heterojunctions?



Barrier height is **reduced** at **forward** biases

Significant **increase** of peak field at **reverse** bias


- 1) Learning to draw **band-diagrams** is one of the most important topics you learn in this course. Band-diagrams are a graphical way of quickly solving the Poisson equation.
- 2) If you consistently follow the rules of drawing band-diagrams, you will always get correct results. Try to follow the rules, **not guess** the final result.

ECE606: Solid State Devices p-n diode I-V characteristics

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- 1) **Derivation of the forward bias formula**
- 2) Solution in the nonlinear regime
- 3) I-V in the ambipolar regime
- 4) Conclusion

Ref. SDF, Chapter 6

	Equilibrium	DC	Small signal	Large Signal	Circuits
Diode					
Schottky			Diode in Non-Equilibrium (External DC voltage applied)		
BJT/HBT					
MOSFET					

$$\nabla \cdot E = q(p - n + N_D^+ - N_A^-)$$

$$\frac{\partial n}{\partial t} = \frac{1}{q} \nabla \cdot \mathbf{J}_N - r_N + g_N$$

$$\mathbf{J}_N = qn\mu_N E + qD_N \nabla n$$

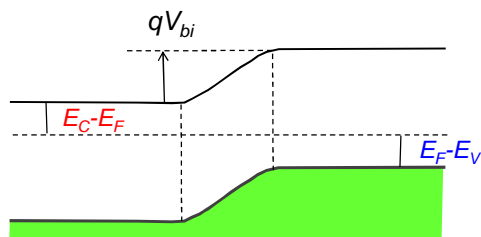
$$\frac{\partial p}{\partial t} = \frac{1}{q} \nabla \cdot \mathbf{J}_P - r_P + g_P$$

$$\mathbf{J}_P = qp\mu_P E - qD_P \nabla p$$

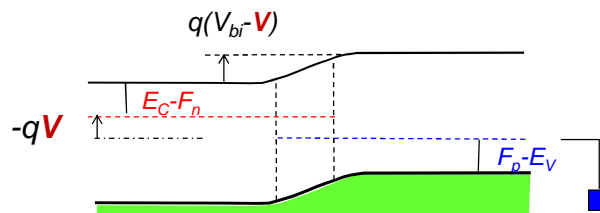
This section

Review

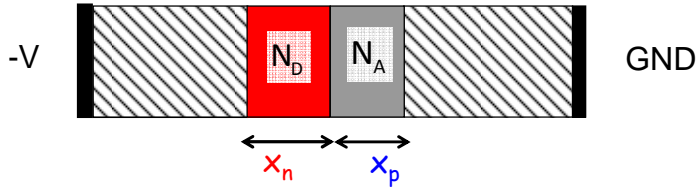
No bias



Applied bias



Review

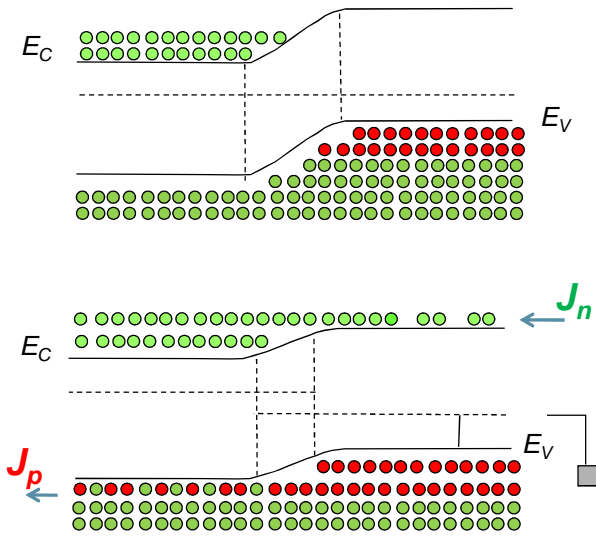


$$N_D x_n = N_A x_p$$

$$q(V_{bi} - V) = \frac{qN_D x_n^2}{2k_s \epsilon_0} + \frac{qN_A x_p^2}{2k_s \epsilon_0}$$

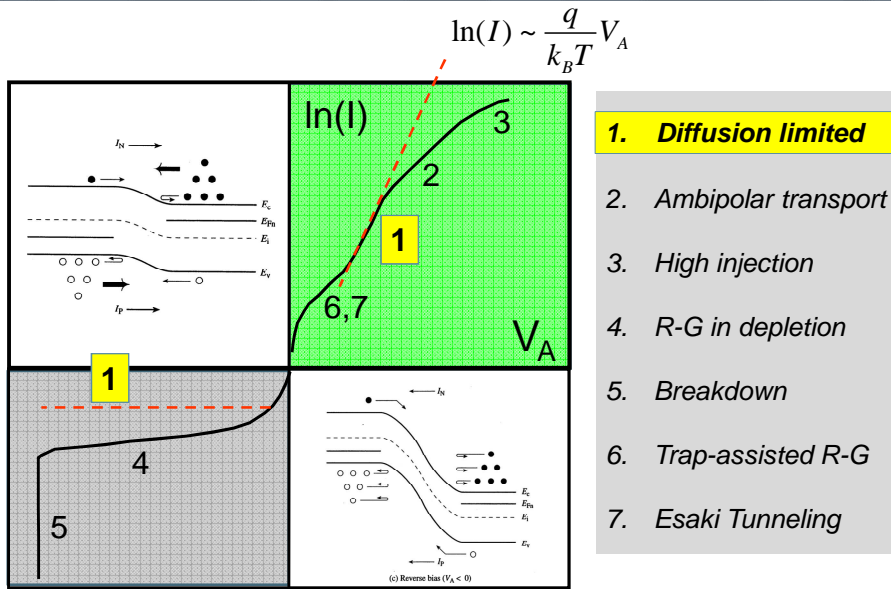
$$x_n = \sqrt{\frac{2k_s \epsilon_0}{q} \frac{N_A}{N_D (N_A + N_D)} (V_{bi} - V)}$$

$$x_p = \sqrt{\frac{2k_s \epsilon_0}{q} \frac{N_D}{N_A (N_A + N_D)} (V_{bi} - V)}$$



Equilibrium: Many electrons N-side. Few electrons P-side.
Detailed balance of drift and diffusion forces. → **No net current**

Forward Bias: Electron J_n and hole J_p currents across junction.
Diffusion force unchanged. (because doping did not change)
But, drift force increased due to applied bias → **Net current**



1. Diffusion limited
2. Ambipolar transport
3. High injection
4. R-G in depletion
5. Breakdown
6. Trap-assisted R-G
7. Esaki Tunneling

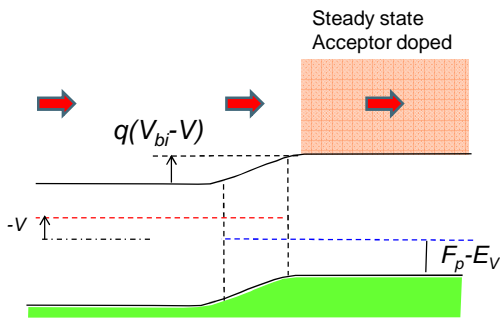
If current is continuous, one can calculate for the current anywhere. Position doesn't matter! Calculate at "easiest" position.

→ Minority carrier current on P-side.
We know the solution from earlier
Assume steady state, no r_n, g_n

$$\frac{\partial n}{\partial t} = \frac{1}{q} \frac{dJ_n}{dx} - r_n + g_n$$

$$J_n = qn\mu_n \mathcal{E} + qD_n \frac{dn}{dx}$$

$$\left. \begin{array}{l} \frac{\partial n}{\partial t} = \frac{1}{q} \frac{dJ_n}{dx} - r_n + g_n \\ J_n = qn\mu_n \mathcal{E} + qD_n \frac{dn}{dx} \end{array} \right\} 0 = D_n \frac{d^2 n}{dx^2}$$



Boundary Conditions

$$n(x=0^+) = n_i e^{(F_n - E_i)\beta}$$

$$p(x=0^+) = n_i e^{-(F_p - E_i)\beta}$$

Difference of Quasi-Fermi-levels equals applied voltage

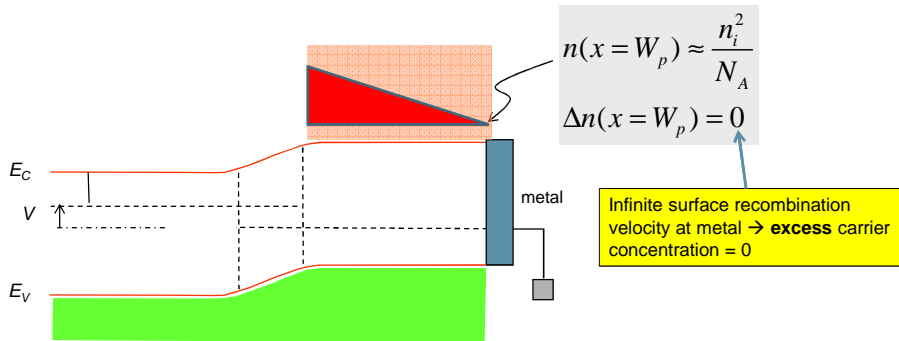
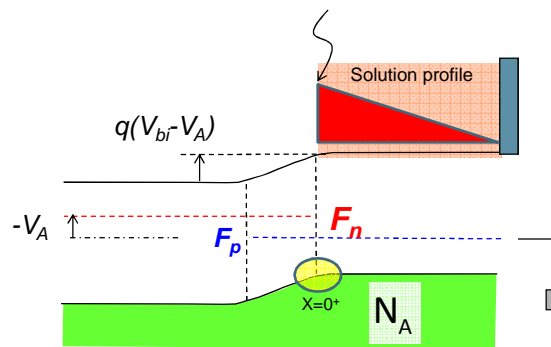
$$np = n_i^2 e^{(F_n - F_p)\beta} = n_i^2 e^{qV_A\beta}$$

$$p(0^+) = N_A$$

$$n(0^+) = \frac{n_i^2}{N_A} e^{qV_A\beta}$$

$$\Delta n(0^+) = n(0^+)_{V_G} - n(0^+)_{V_G=0}$$

$$= \frac{n_i^2}{N_A} (e^{qV_A\beta} - 1)$$



$$n(x=W_p) \approx \frac{n_i^2}{N_A}$$

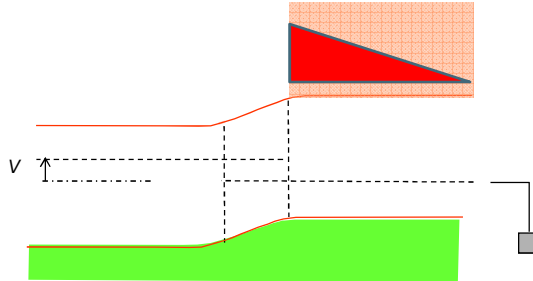
$$\Delta n(x=W_p) = 0$$

Infinite surface recombination velocity at metal \rightarrow excess carrier concentration = 0

$$D_N \frac{d^2 n}{dx^2} = 0$$

Ansatz

$$\Delta n(x, t) = C + Dx$$



Plug in B.C.

$$x = W_p, \quad \Delta n(x = W_p) = 0 \Rightarrow C = -DW_p$$

$$x = 0, \quad \Delta n(x = 0) = \frac{n_i^2}{N_A} (e^{qV_A \beta} - 1) = C$$

$$\Delta n(x, t) = \frac{n_i^2}{N_A} (e^{qV_A \beta} - 1) \left(1 - \frac{x}{W_p} \right)$$

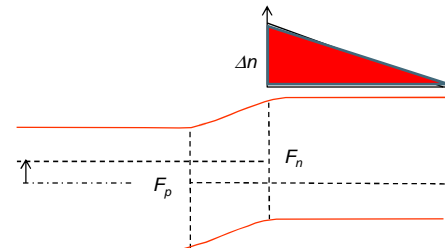
Final result: Excess electron carrier concentration (P-side) as function of position

$$\Delta n(x) = \frac{n_i^2}{N_A} (e^{qV_A \beta} - 1) \left(1 - \frac{x}{W_p} \right)$$

$$\mathbf{J}_N = qn\mu_N \mathbf{E} + qD_N \nabla n$$

Current (electrons)

$$J_n = qD_n \left. \frac{dn}{dx} \right|_{x=0} = -\frac{qD_n}{W_p} \frac{n_i^2}{N_A} (e^{qV_A \beta} - 1)$$



Current (holes)

$$J_p = -qD_p \left. \frac{dp}{dx} \right|_{x=0} = -\frac{qD_p}{W_n} \frac{n_i^2}{N_D} (e^{qV_A \beta} - 1)$$

Forward Bias

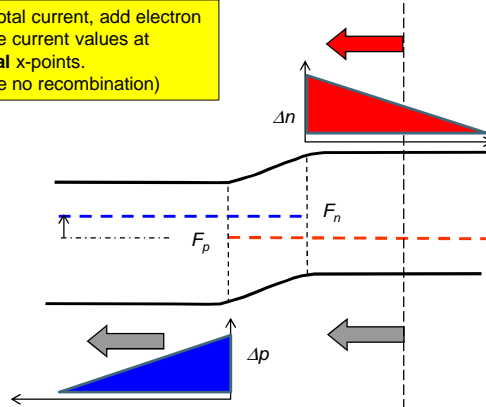
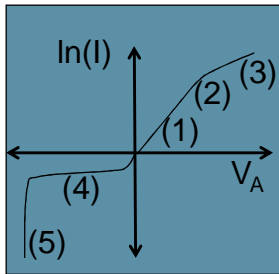
$$\ln J_T \approx qV_A/k_B T + \ln(const.)$$

Reverse Bias

$$J_T \approx const. \quad \text{Diffusion current}$$

$$J_T = -q \left[\frac{D_n n_i^2}{W_p N_A} + \frac{D_p n_i^2}{W_n N_D} \right] (e^{qV_{AB}} - 1)$$

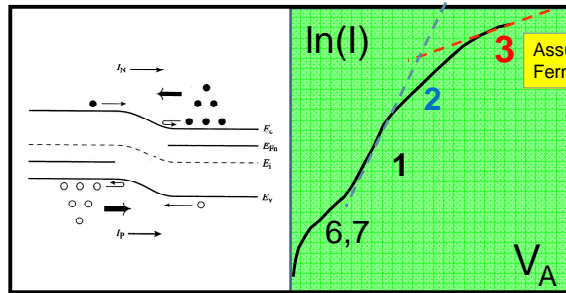
To get total current, add electron and hole current values at identical x-points. (assume no recombination)



- 1) Derivation of the forward bias formula
- 2) **Solution in the nonlinear regime**
- 3) I-V in the ambipolar regime
- 4) Conclusion

$$J_T = -q \left[\frac{D_n}{W_p} \frac{n_i^2}{N_A} + \frac{D_p}{W_n} \frac{n_i^2}{N_D} \right] \left(e^{(qV_A - \Delta F_n - \Delta F_p)\beta} - 1 \right) = I_0 \left(e^{q(V_A - aJ_n - bJ_p)\beta} - 1 \right)$$

Today's lecture: Nonlinear Regime (2,3)



Assumption of flat Quasi-Fermi levels invalid here

$$J_N = qn\mu_n \mathcal{E} + qD_N \frac{dn}{dx}$$

$$J_n = n\mu_n \frac{dF_n}{dx} \Rightarrow \Delta F_n = \frac{J_n W_n}{\mu_n N_D}$$

Rewrite n into non-equilibrium form, re-arrange J_n equation

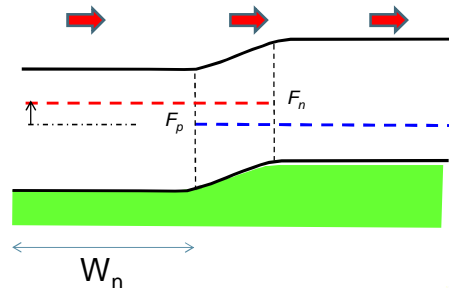
$$n = n_i e^{\beta(F_n - E_i)} \quad qD_N \frac{dn}{dx} = qD_N \beta \left[\frac{dF_n}{dx} - \mathcal{E} \right] \left[n_i e^{\beta(F_n - E_i)} \right]$$

Drop of Quasi-Fermi level across the junction proportional to current!

New diffusion component: Plug this into original J_n equation

$$qD_N \frac{dn}{dx} = qD_N n \beta \left[\frac{dF_n}{dx} - \mathcal{E} \right]$$

$$= q\mu_n n \left[\frac{dF_n}{dx} - \mathcal{E} \right] \quad \therefore \frac{D_N}{\mu_n} = \frac{k_B T}{q}$$

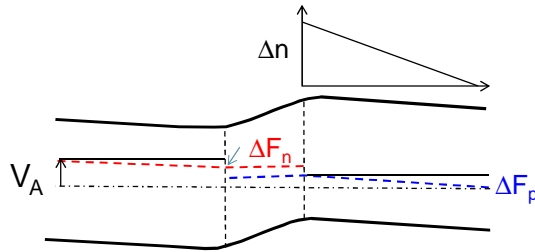


$$n(0^+) = \frac{n_i^2}{N_A} e^{(F_n - F_p)\beta} \Big|_{\text{junction}} = \frac{n_i^2}{N_A} e^{(qV_A - \Delta F_n - \Delta F_p)\beta} \Rightarrow \Delta n(0^+) = \frac{n_i^2}{N_A} \left(e^{(qV_A - \Delta F_n - \Delta F_p)\beta} - 1 \right)$$

$$J_T = -q \left[\frac{D_n}{W_p} \frac{n_i^2}{N_A} + \frac{D_p}{W_n} \frac{n_i^2}{N_D} \right] \left(e^{(qV_A - \Delta F_n - \Delta F_p)\beta} - 1 \right)$$

$$\Delta F_n = \frac{J_n W_n}{\mu_n N_D}$$

$$\Delta F_p = \frac{J_p W_p}{\mu_n N_D}$$



Still diffusion dominated transport? Since Quasi-Fermi levels are not flat in nonlinear regime (drift), this approximation becomes worse.

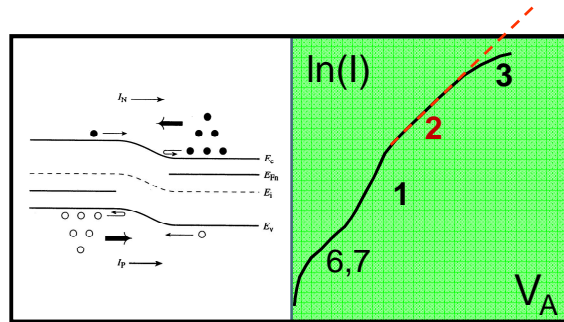
- 1) Derivation of the forward bias formula
- 2) Solution in the nonlinear regime
- 3) I-V in the ambipolar regime**
- 4) Tunneling and I-V characteristics
- 5) Conclusion

$$J_T \approx -q \left[\frac{D_n}{W_p} + \frac{D_p}{W_n} \right] n_i e^{(qV_A - \Delta F_n - \Delta F_p)\beta/2}$$

$$\ln(J_T) \approx \frac{qV_A}{2k_B T}$$

Today's lecture: **Ambipolar** Transport regime (2)

Question: Where does the 2 come from?



$$np = n_i^2 e^{(F_n - F_p)\beta}$$

Here not negligibly small. Ambipolar transport !

$$\left(\frac{n_i^2}{N_A} + \Delta n \right) (N_A + \Delta p) = n_i^2 \left(e^{q(V_A - \Delta F_n - \Delta F_p)\beta} - 1 \right)$$

Excess carrier concentrations $\gg N_A$ Thus...

$$\Delta n \approx \Delta p = n_i \sqrt{e^{q(V_A - \Delta F_n - \Delta F_p)\beta} - 1}$$

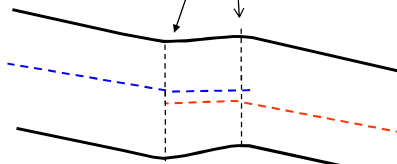
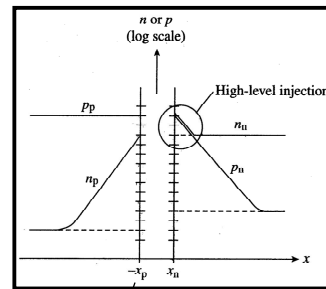
$$\approx n_i e^{q(V_A - \Delta F_n - \Delta F_p)\beta/2}$$

Currents

$$J_n = -qD_n \frac{\Delta n}{W_p} = \frac{qD_n n_i}{W_p} e^{q(V_A - \Delta F_n - \Delta F_p)\beta/2}$$

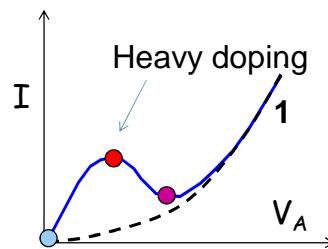
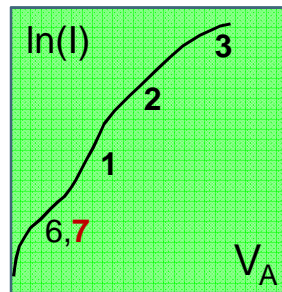
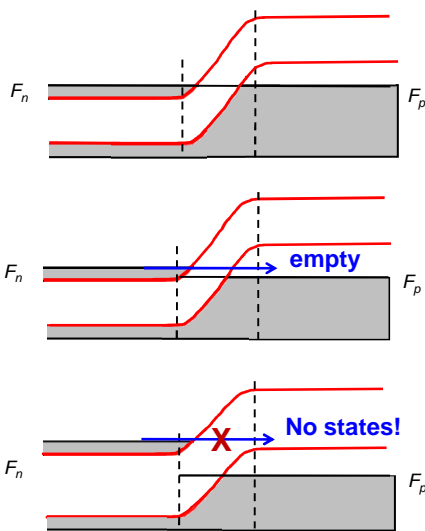
$$J_p = -qD_p \frac{\Delta p}{W_n} = \frac{qD_p n_i}{W_n} e^{q(V_A - \Delta F_n - \Delta F_p)\beta/2}$$

Note: junction never disappears, even for large forward bias!

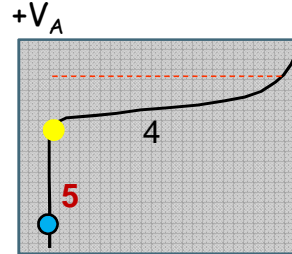
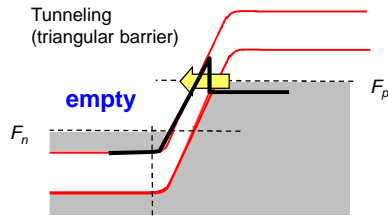


- 1) Derivation of the forward bias formula
- 2) Solution in the nonlinear regime
- 3) I-V in the ambipolar regime
- 4) **Tunneling and I-V characteristics**
- 5) Conclusion

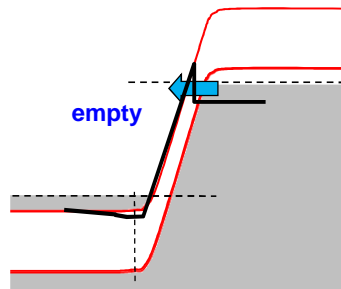
Esaki-Diode: **Heavily** doped diode



Tunneling in diodes.
Nobel Prize
(Esaki)



Zener tunneling occurs in every diode. (reverse bias)



Remember: Tunneling through a triangular barrier

$$I = qT \nu$$

$$T = \frac{4}{4 \cosh^2 \alpha d + \left(\frac{\alpha}{k} - \frac{k}{\alpha}\right) \sinh^2 \alpha d}$$

(p.49 ADF)

- 1) I-V characteristics of a p-n junction is defined by many interesting phenomena including diffusion, ambipolar transport, tunneling etc.
- 2) The separate regions are identified by specific features. Once we learn to identify them, we can see if one or the other mechanism is dominated for a given technology.
- 3) In the next class, we will discuss a few more non-ideal effects.